Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/810,718	ANDRICACOS ET AL.
Examiner	Art Unit
Edna Wong	1753

	SEAR	CHED	
	JEAN	CHED	
Class	Subclass	Date	Examiner
106	1.26	3/6/2006	EW
205	291	3/6/2006	EW
205	296	3/6/2006	EW
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

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	DATE	EXMR
Inventor Seach	3/6/2006	EW
EAST	3/6/2006	ew
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